


M. Flom Associates, Inc. is accredited by the American Association for Laboratory Association (A2LA) as shown in the scope below.



THE AMERICAN ASSOCIATION FOR LABORATORY ACCREDITATION

ACCREDITED LABORATORY

A2LA has accredited


M. FLOM ASSOCIATES, INC.
Chandler, AZ

for technical competence in the field of

Electrical (EMC) Testing


The accreditation covers the specific tests and types of tests listed on the agreed scope of accreditation. This laboratory meets the requirements of ISO/IEC Guide 25-1990 "General Requirements for the Competence of Calibration and Testing Laboratories" (equivalent to relevant requirements of the ISO 9000 series of standards) and any additional program requirements in the identified field of testing.

Presented this 24th day of November, 1998.



Peter Almy
President
For the Accreditation Council
Certificate Number 1008.01
Valid to December 31, 2000

For tests or types of tests to which this accreditation applies, please refer to the laboratory's Electrical (EMC) Scope of Accreditation



American Association for Laboratory Accreditation

SCOPE OF ACCREDITATION TO ISO/IEC GUIDE 25-1990 AND EN 45001

M. FLOM ASSOCIATES, INC.
Electronic Testing Laboratory
3156 North San Marcos Place, Suite 107
Chandler, AZ 85224-1571
Morton Flom Phone: 602 926 3100

ELECTRICAL (EMC)

Valid to: December 31, 2000 Certificate Number: 1008-01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following electromagnetic compatibility tests:

Tests	Standards
RF Emission	FCC Part 15 (Subparts B and C) using ANSI C63.4-1992; CISPR 11; CISPR 13; CISPR 14; CISPR 22; EN 55011; EN 55013; EN 55014; EN 55022; EN 50081-1; EN 50081-2; FCC Part 15; KCES-003; AS/NZS 1044; AS/NZS 1453; AS/NZS 3548; AS/NZS 451.1
RF Immunity	EN 50082-1; EN 50082-2; AS/NZS 451.1
Radiated Susceptibility	EN 61000-4-3; ENV 50140; ENV 50204; IEC 1000-4-3; IEC 801-3
ESD	EN 61000-4-2; IEC 1000-4-2; IEC 801-2
EFT	EN 61000-4-4; IEC 1000-4-4; IEC 801-4
Surge	EN 61000-4-5; ENV 50142; IEC 1000-4-5; IEC 801-5
47 CFR (FCC)	2, 21, 22, 23, 24, 74, 88, 87, 90, 95, 97

Peter Almy

5301 Budagystown Pike, Suite 350 • Frederick, MD 21704-8307 • Phone: 301 664 3200 • Fax: 301 662 2974

"This laboratory is accredited by the American Association for Laboratory Accreditation (A2LA) and the results shown in this report have been determined in accordance with the laboratory's terms of accreditation unless stated otherwise in the report."

Should this report contain any data for tests for which we are not accredited, or which have been undertaken by a subcontractor that is not A2LA accredited, such data would not covered by this laboratory's A2LA accreditation.

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Subpart 2.1033 (continued)

(c) (8): VOLTAGES & CURRENTS IN ALL ELEMENTS IN FINAL R. F. STAGE,
INCLUDING FINAL TRANSISTOR OR SOLID STATE DEVICE:

COLLECTOR CURRENT, A = per manual
COLLECTOR VOLTAGE, Vdc = per manual
SUPPLY VOLTAGE, Vdc = 7.5

(c) (9): TUNE-UP PROCEDURE:

PLEASE SEE ATTACHED EXHIBITS

(c) (10): CIRCUIT DIAGRAM/CIRCUIT DESCRIPTION:

Including description of circuitry & devices provided for determining and stabilizing frequency, for suppression of spurious radiation, for limiting modulation and limiting power.

PLEASE SEE ATTACHED EXHIBITS

(c) (11): LABEL INFORMATION:

PLEASE SEE ATTACHED EXHIBITS

(c) (12): PHOTOGRAPHS:

PLEASE SEE ATTACHED EXHIBITS

(c) (13): DIGITAL MODULATION DESCRIPTION:

 ATTACHED EXHIBITS
 x N/A

(c) (14): TEST AND MEASUREMENT DATA:

FOLLOWS

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Sub-part

2.1033(c) (14):TEST AND MEASUREMENT DATA

All tests and measurement data shown were performed in accordance with FCC Rules and Regulations, Volume II; Part 2, Sub-part J, Sections 2.947, 2.1033(c), 2.1041, 2.1046, 2.1047, 2.1079, 2.1051, 2.1053, 2.1055, 2.1057 and the following individual Parts:

- 21 - Domestic Public Fixed Radio Services
- 22 - Public Mobile Services
- 22 Subpart H - Cellular Radiotelephone Service
- 22.901(d) - Alternative technologies and auxiliary services
- 23 - International Fixed Public Radiocommunication services
- 24 - Personal Communications Services
- 74 Subpart H - Low Power Auxiliary Stations
- 80 - Stations in the Maritime Services
- 80 Subpart E - General Technical Standards
- 80 Subpart F - Equipment Authorization for Compulsory Ships
- 80 Subpart K - Private Coast Stations and Marine Utility Stations
- 80 Subpart S - Compulsory Radiotelephone Installations for Small Passenger Boats
- 80 Subpart T - Radiotelephone Installation Required for Vessels on the Great Lakes
- 80 Subpart U - Radiotelephone Installations Required by the Bridge-to-Bridge Act
- 80 Subpart V - Emergency Position Indicating Radiobeacons (EPIRB'S)
- 80 Subpart W - Global Maritime Distress and Safety System (GMDSS)
- 80 Subpart X - Voluntary Radio Installations
- 87 - Aviation Services
- 90 - Private Land Mobile Radio Services
- 94 - Private Operational-Fixed Microwave Service
- 95 Subpart A - General Mobile Radio Service (GMRS)
- 95 Subpart C - Radio Control (R/C) Radio Service
- 95 Subpart D - Citizens Band (CB) Radio Service
- 95 Subpart E - Family Radio Service
- 95 Subpart F - Interactive Video and Data Service (IVDS)
- 101 - Fixed Microwave Services

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STANDARD TEST CONDITIONS
and
ENGINEERING PRACTICES

Except as noted herein, the following conditions and procedures were observed during the testing:

In accordance with ANSI C63.4-1992, section 6.1.9, and unless otherwise indicated in the specific measurement results, the ambient temperature of the actual EUT was maintained within the range of 10° to 40°C (50° to 104 °F) unless the particular equipment requirements specify testing over a different temperature range. Also, unless otherwise indicated, the humidity levels were in the range of 10% to 90% relative humidity.

Prior to testing, the EUT was tuned up in accordance with the manufacturer's alignment procedures. All external gain controls were maintained at the position of maximum and/or optimum gain throughout the testing.

Measurement results, unless otherwise noted, are worst case measurements.

PAGE NO. 7 of 42.
NAME OF TEST: Carrier Output Power (Conducted)
SPECIFICATION: 47 CFR 2.1046(a)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.1
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT was connected to a resistive coaxial attenuator of normal load impedance, and the unmodulated output power was measured by means of an R. F. Power Meter.
2. Measurement accuracy is $\pm 3\%$.

MEASUREMENT RESULTS
(Worst case)

FREQUENCY OF CARRIER, MHz = 162.02, 150.02, 173.98

<u>POWER SETTING</u>	<u>R. F. POWER, WATTS</u>
Low	0.5
High	4

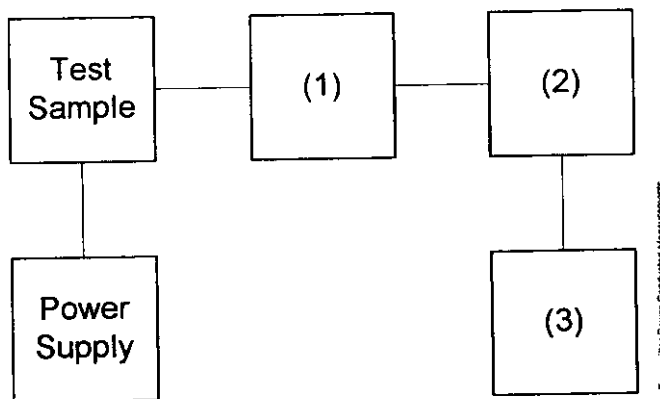
SUPERVISED BY:

Morton Flom P. Eng.

Morton Flom, P. Eng.

TRANSMITTER POWER CONDUCTED MEASUREMENTS

TEST 1: R. F. POWER OUTPUT
 TEST 2: FREQUENCY STABILITY



Asset	Description	s/n
(1)	<u>COAXIAL ATTENUATOR</u>	
_____	i00122 Narda 766-10	7802
_____	i00123 Narda 766-10	7802A
_____	i00069 Bird 8329 (30 dB)	1006
<u>x</u>	i00113 Sierra 661A-3D	1059
(2)	<u>POWER METERS</u>	
_____	i00014 HP 435A	1733A05836
<u>x</u>	i00039 HP 436A	2709A26776
<u>x</u>	i00020 HP 8901A POWER MODE	2105A01087
(3)	<u>FREQUENCY COUNTER</u>	
_____	i00042 HP 5383A	1628A00959
<u>x</u>	i00019 HP 5334B	2704A00347
<u>x</u>	i00020 HP 8901A FREQUENCY MODE	2105A01087

PAGE NO. 9 of 42.
NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
SPECIFICATION: 47 CFR 2.1051
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.13
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The emissions were measured for the worst case as follows:
 - (a): within a band of frequencies defined by the carrier frequency plus and minus one channel.
 - (b): from the lowest frequency generated in the EUT and to at least the 10th harmonic of the carrier frequency, or 40 GHz, whichever is lower.
2. The magnitude of spurious emissions that are attenuated more than 20 dB below the permissible value need not be specified.
3. MEASUREMENT RESULTS: ATTACHED FOR WORST CASE

FREQUENCY OF CARRIER, MHz = 162.02, 150.02, 173.98
 SPECTRUM SEARCHED, GHz = 0 to 10 x F_c
 MAXIMUM RESPONSE, Hz = 3160
 ALL OTHER EMISSIONS = ≥ 20 dB BELOW LIMIT
 LIMIT(S), dBc

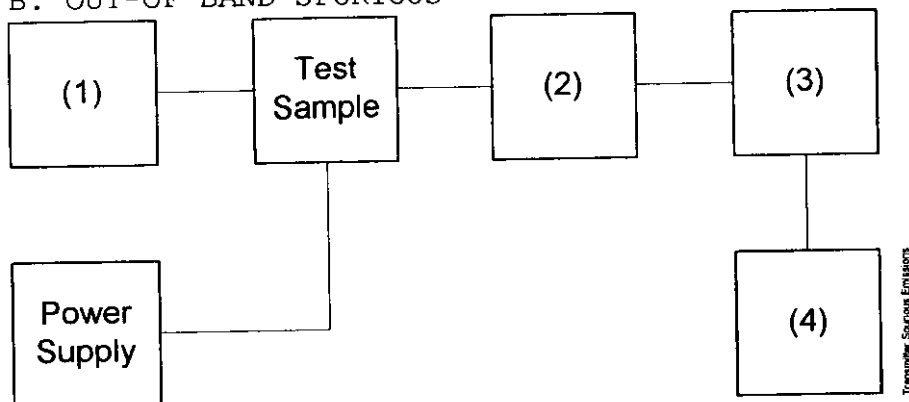
-(50+10xLOG P) = -47 (0.5 Watts)
 -(50+10xLOG P) = -56 (4 Watts)

SUPERVISED BY:


 Morton Flom, P. Eng.

TRANSMITTER SPURIOUS EMISSION

TEST A. OCCUPIED BANDWIDTH (IN-BAND SPURIOUS)
 TEST B. OUT-OF-BAND SPURIOUS



Asset	Description	s/n
<u>(1) AUDIO OSCILLATOR/GENERATOR</u>		
—	i00010 HP 204D	1105A04683
—	i00017 HP 8903A	2216A01753
x	i00012 HP 3312A	1432A11250
<u>(2) COAXIAL ATTENUATOR</u>		
—	i00122 Narda 766-10	7802
—	i00123 Narda 766-10	7802A
x	i00069 Bird 8329 (30 dB)	1006
x	i00113 Sierra 661A-3D	1059
<u>(3) FILTERS; NOTCH, HP, LP, BP</u>		
x	i00126 Eagle TNF-1	100-250
x	i00125 Eagle TNF-1	50-60
x	i00124 Eagle TNF-1	250-850
<u>(4) SPECTRUM ANALYZER</u>		
x	i00048 HP 8566B	2511A01467
—	i00029 HP 8563E	3213A00104

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
 g9960241: 1999-Jun-24 Thu 08:24:00
 STATE: 1:Low Power

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
150.020000	300.039000	-41.2	-68.2	-21.2
162.020000	324.038000	-40.4	-67.4	-20.4
173.980000	347.966000	-42.9	-69.9	-22.9
150.020000	450.072000	-45.2	-72.2	-25.2
162.020000	486.060000	-43.9	-70.9	-23.9
173.980000	521.937000	-41.5	-68.5	-21.5
150.020000	600.092000	-55.1	-82.1	-35.1
162.020000	647.983000	-56	-83	-36
173.980000	695.585000	-57.2	-84.2	-37.2
150.020000	749.815000	-57.9	-84.9	-37.9
162.020000	809.677000	-56.2	-83.2	-36.2
173.980000	870.074000	-57.3	-84.3	-37.3
150.020000	899.823000	-57.1	-84.1	-37.1
162.020000	972.290000	-56.5	-83.5	-36.5
173.980000	1044.323000	-56.7	-83.7	-36.7
150.020000	1049.899000	-57.2	-84.2	-37.2
162.020000	1133.799000	-56.5	-83.5	-36.5
150.020000	1200.344000	-57.1	-84.1	-37.1
173.980000	1218.100000	-57.4	-84.4	-37.4
162.020000	1296.161000	-56.3	-83.3	-36.3
150.020000	1350.053000	-56.5	-83.5	-36.5
173.980000	1391.660000	-56.9	-83.9	-36.9
162.020000	1458.656000	-56.4	-83.4	-36.4
150.020000	1500.060000	-57.3	-84.3	-37.3
173.980000	1566.308000	-57.2	-84.2	-37.2
162.020000	1619.741000	-56.2	-83.2	-36.2
150.020000	1649.895000	-55.8	-82.8	-35.8
173.980000	1739.433000	-57.2	-84.2	-37.2
162.020000	1782.686000	-56.5	-83.5	-36.5
150.020000	1800.201000	-55.8	-82.8	-35.8
173.980000	1913.534000	-55.7	-82.7	-35.7
162.020000	1944.554000	-56.9	-83.9	-36.9
150.020000	1949.898000	-56.3	-83.3	-36.3
173.980000	2088.011000	-56.1	-83.1	-36.1
150.020000	2100.141000	-56.5	-83.5	-36.5
162.020000	2106.665000	-57.2	-84.2	-37.2
150.020000	2250.278000	-56.7	-83.7	-36.7
173.980000	2262.160000	-56	-83	-36
162.020000	2268.047000	-54.9	-81.9	-34.9
162.020000	2430.695000	-55.8	-82.8	-35.8
173.980000	2436.166000	-55.4	-82.4	-35.4
173.980000	2609.786000	-57.9	-84.9	-37.9

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
 g9960240: 1999-Jun-24 Thu 08:13:00
 STATE: 2:High Power

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
150.020000	300.046000	-38.9	-74.9	-18.9
162.020000	324.031000	-37.8	-73.8	-17.8
173.980000	347.954000	-36.5	-72.5	-16.5
150.020000	450.069000	-44.3	-80.3	-24.3
162.020000	486.079000	-41.2	-77.2	-21.2
173.980000	521.942000	-29.9	-65.9	-9.9
150.020000	600.110000	-46.1	-82.1	-26.1
162.020000	648.204000	-45.1	-81.1	-25.1
173.980000	695.755000	-45.8	-81.8	-25.8
150.020000	750.336000	-44.1	-80.1	-24.1
162.020000	810.046000	-44.4	-80.4	-24.4
173.980000	869.935000	-44.4	-80.4	-24.4
150.020000	900.076000	-44.9	-80.9	-24.9
162.020000	971.710000	-45.9	-81.9	-25.9
173.980000	1043.449000	-45.4	-81.4	-25.4
150.020000	1050.060000	-45.3	-81.3	-25.3
162.020000	1134.205000	-45.5	-81.5	-25.5
150.020000	1199.967000	-43.2	-79.2	-23.2
173.980000	1218.222000	-45.3	-81.3	-25.3
162.020000	1296.095000	-44.3	-80.3	-24.3
150.020000	1349.871000	-45.4	-81.4	-25.4
173.980000	1392.264000	-45.4	-81.4	-25.4
162.020000	1457.686000	-45.5	-81.5	-25.5
150.020000	1499.758000	-45	-81	-25
173.980000	1565.406000	-45	-81	-25
162.020000	1620.625000	-45.2	-81.2	-25.2
150.020000	1649.819000	-46	-82	-26
173.980000	1739.780000	-45.1	-81.1	-25.1
162.020000	1781.916000	-43.7	-79.7	-23.7
150.020000	1800.157000	-44.7	-80.7	-24.7
173.980000	1913.380000	-44.6	-80.6	-24.6
162.020000	1944.064000	-44	-80	-24
150.020000	1950.108000	-43.7	-79.7	-23.7
173.980000	2088.107000	-44	-80	-24
150.020000	2100.179000	-44.8	-80.8	-24.8
162.020000	2106.020000	-44.7	-80.7	-24.7
150.020000	2250.181000	-44.4	-80.4	-24.4
173.980000	2262.132000	-43.6	-79.6	-23.6
162.020000	2268.151000	-44.2	-80.2	-24.2
162.020000	2430.616000	-43.7	-79.7	-23.7
173.980000	2435.421000	-44.5	-80.5	-24.5
173.980000	2609.965000	-46.4	-82.4	-26.4

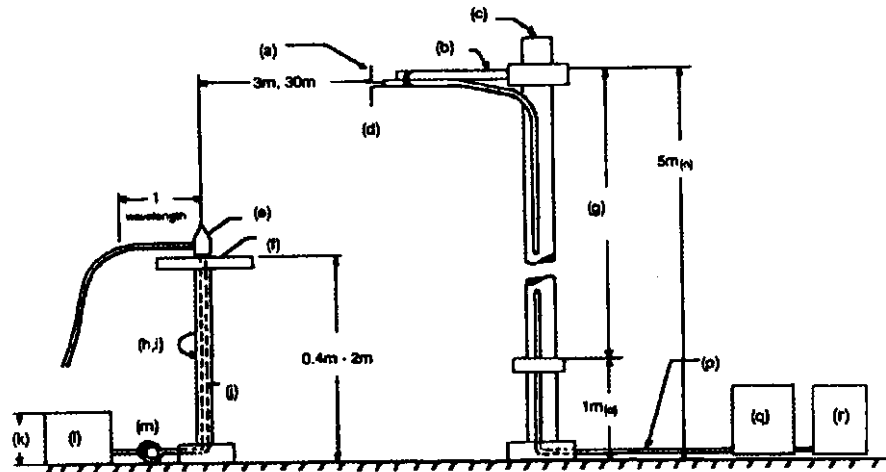
PAGE NO. 13 of 42.
NAME OF TEST: Field Strength of Spurious Radiation
SPECIFICATION: 47 CFR 2.1053(a)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.12
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. A description of the measurement facilities was filed with the FCC and was found to be in compliance with the requirements of Section 2.948, by letter from the FCC dated March 3, 1997, FILE 31040/SIT. All pertinent changes will be reported to the Commission by up-date prior to March 2000.
2. At first, in order to locate all spurious frequencies and approximate amplitudes, and to determine proper equipment functioning, the test sample was set up at a distance of three meters from the test instrument. Valid spurious signals were determined by switching the power on and off.
3. In the field, the test sample was placed on a wooden turntable above ground at three (or thirty) meters away from the search antenna. Excess power leads were coiled near the power supply.

The cables were oriented in order to obtain the maximum response. At each emission frequency, the turntable was rotated and the search antennas were raised and lowered vertically.
4. The emission was observed with both a vertically polarized and a horizontally polarized search antenna and the worst case was used.
6. The field strength of each emission within 20 dB of the limit was recorded and corrected with the appropriate cable and transducer factors.
7. The worst case for all channels is shown.
8. Measurement results: ATTACHED FOR WORST CASE

RADIATED TEST SETUP



NOTES:

- (a) Search Antenna - Rotatable on boom
- (b) Non-metallic boom
- (c) Non-metallic mast
- (d) Adjustable horizontally
- (e) Equipment Under Test
- (f) Turntable
- (g) Boom adjustable in height.
- (h) External control cables routed horizontally at least one wavelength.
- (i) Rotatable
- (j) Cables routed through hollow turntable center
- (k) 30 cm or less
- (l) External power source
- (m) 10 cm diameter coil of excess cable
- (n) 25 cm (V), 1 m-7 m (V, H)
- (o) 25 cm from bottom end of 'V', 1m normally
- (p) Calibrated Cable at least 10m in length
- (q) Amplifier (optional)
- (r) Spectrum Analyzer

Asset	Description	s/n	Cycle	Last Cal
<u>TRANSDUCER</u>				
___	i00065 EMCO 3109B 100Hz-50MHz	2336	12 mo.	
___	i00033 Singer 94593-1 10kHz-32MHz	0219	12 mo.	
x	i00088 EMCO 3109-B 25MHz-300MHz	2336	12 mo.	Oct-98
x	i00089 April 2001 200MHz-1GHz	001500	12 mo.	Oct-98
x	i00103 EMCO 3115 1GHz-18GHz	9208-3925	12 mo.	Oct-98
___	i00085 EMCO 3116 10GHz-40GHz	2076	12 mo.	
<u>AMPLIFIER</u>				
___	i00028 HP 8449A	2749A00121	12 mo.	Mar-99
<u>SPECTRUM ANALYZER</u>				
___	i00029 HP 8563E	3213A00104	12 mo.	Aug-98
x	i00033 HP 85462A	3625A00357	12 mo.	Dec-98
___	i00048 HP 8566B	2511AD1467	6 mo.	Dec-98

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NAME OF TEST: Field Strength of Spurious Radiation

ALL OTHER EMISSIONS = \geq 20 dB BELOW LIMIT

EMISSION, MHz/HARMONIC	SPURIOUS LEVEL, dBc	
	Low	High
2nd to 10th	<-60	<-65

SUPERVISED BY:

Morton Flom, P. Eng.

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NAME OF TEST: Field Strength of Spurious Radiation
 g9960249: 1999-Jun-25 Fri 08:15:00
 STATE: 2:High Power

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	CF, dB	uV/m @ 3m	ERP, dBm	MARGIN, dB
162.020000	324.046000	38.88	19.7	849.18	-38.75	-18.8
162.020000	486.058000	40.77	23.72	1676.87	-32.85	-12.9
162.020000	648.079000	33.07	27.84	1110.45	-36.45	-16.5
162.020000	810.101000	21.95	29.93	392.64	-45.45	-25.5
162.020000	972.124000	21.72	36.99	861.99	-38.65	-18.7
162.020000	1134.148000	11.62	33.54	181.13	-52.25	-32.2
162.020000	1296.165000	9.59	35.41	177.83	-52.35	-32.4
162.020000	1458.182000	10.41	37.09	237.14	-49.85	-29.9
162.020000	1620.208000	7.09	38.63	193.2	-51.65	-31.7

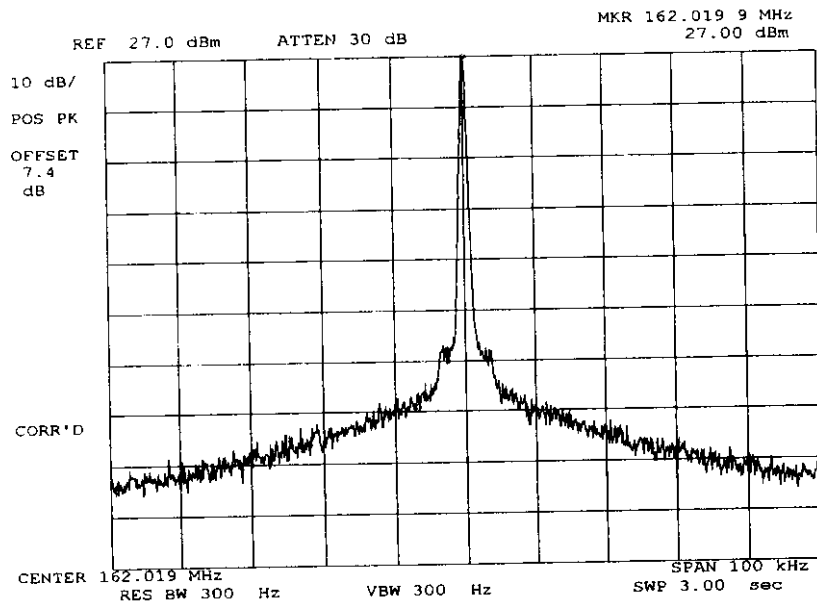
PAGE NO. 17 of 42.
NAME OF TEST: Emission Masks (Occupied Bandwidth)
SPECIFICATION: 47 CFR 2.1049(c)(1)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.11
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page, with the Spectrum Analyzer connected.
2. For EUTs supporting audio modulation, the audio signal generator was adjusted to the frequency of maximum response and with output level set for ± 2.5 kHz deviation (or 50% modulation). With level constant, the signal level was increased 16 dB.
3. For EUTs supporting digital modulation, the digital modulation mode was operated to its maximum extent.
4. The Occupied Bandwidth was measured with the Spectrum Analyzer controls set as shown on the test results.
5. MEASUREMENT RESULTS: ATTACHED

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g9960235: 1999-Jun-24 Thu 08:01:00
STATE: 1:Low Power



POWER: LOW
MODULATION: NONE

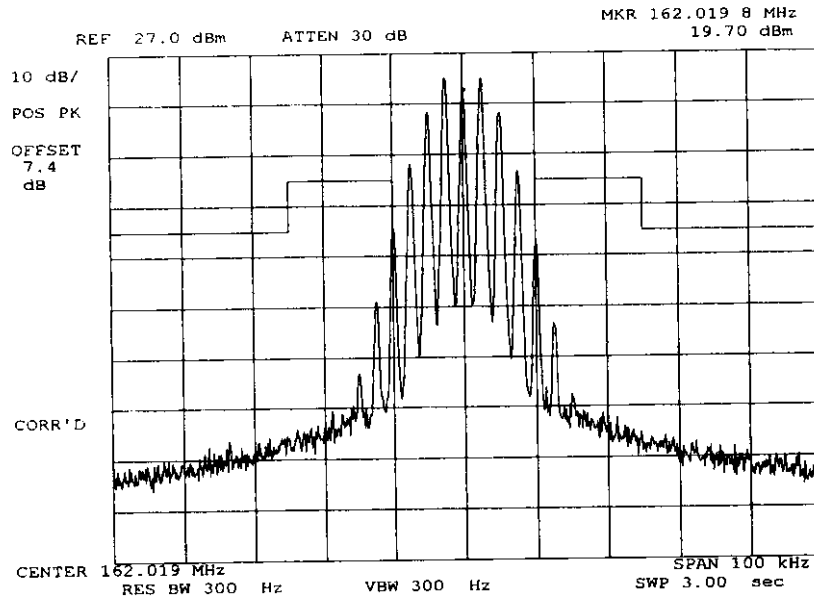
SUPERVISED BY:

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Morton Flom, P. Eng.

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g9960237: 1999-Jun-24 Thu 08:04:00
STATE: 1:Low Power



POWER:
MODULATION:

LOW
VOICE: 2500 Hz SINE WAVE
MASK: B, VHF/UHF 25kHz,
w/LPF

SUPERVISED BY:

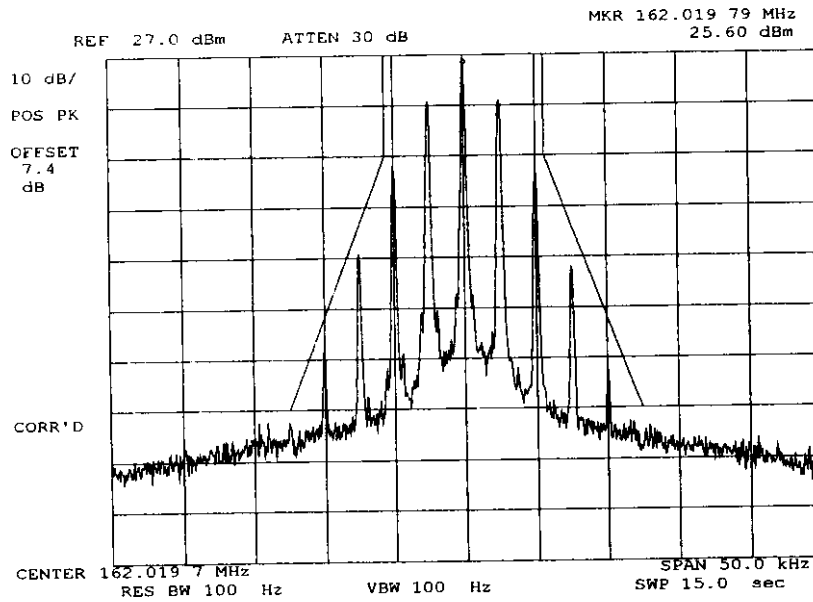
Morton Flom P. Eng.

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g9960239: 1999-Jun-24 Thu 08:11:00
STATE: 1:Low Power



POWER:
MODULATION:

LOW
VOICE: 2500 Hz SINE WAVE
MASK: D, VHF/UHF 12.5kHz BW

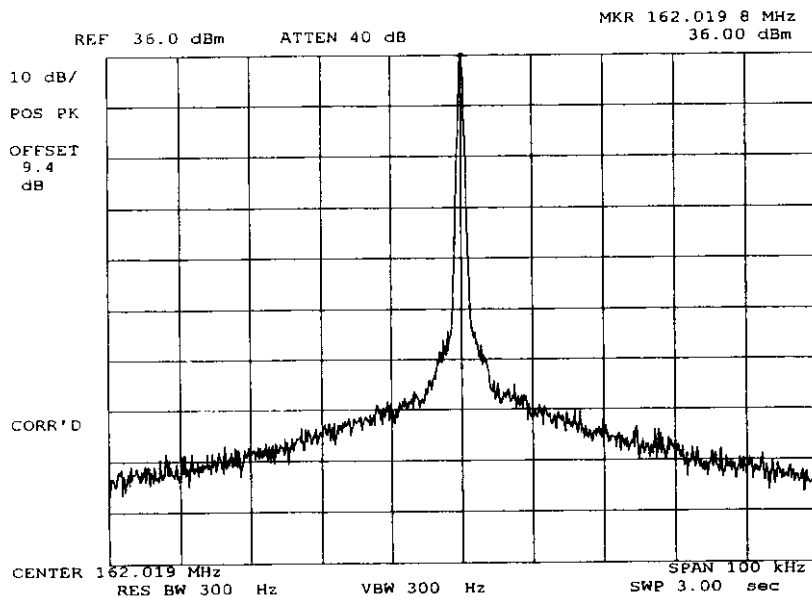
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g9960234: 1999-Jun-24 Thu 07:58:00
STATE: 2:High Power



POWER:
MODULATION:

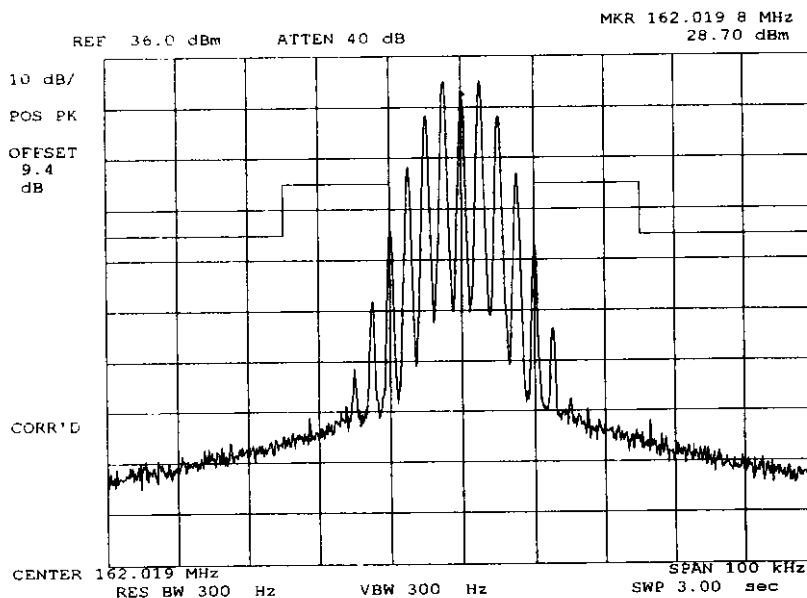
HIGH
NONE

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Morton Flom P. Eng.
Morton Flom, P. Eng.

PAGE NO. 22 of 42.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
g9960236: 1999-Jun-24 Thu 08:03:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
VOICE: 2500 Hz SINE WAVE
MASK: B, VHF/UHF 25kHz,
w/LPF

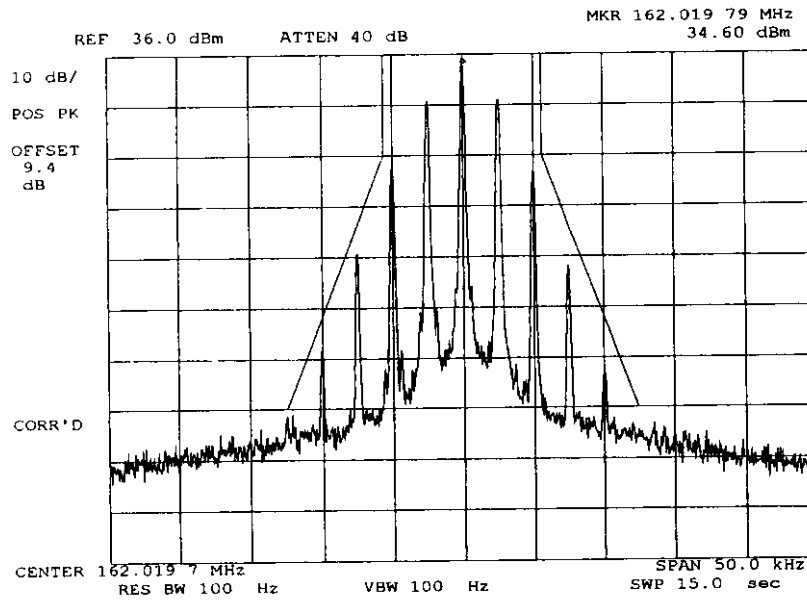
SUPERVISED BY:

Morton Flom P. Eng.
Morton Flom, P. Eng.

PAGE NO.

23 of 42.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
g9960238: 1999-Jun-24 Thu 08:08:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
VOICE: 2500 Hz SINE WAVE
MASK: D, VHF/UHF 12.5kHz BW

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Morton Flom, P. Eng.

PAGE NO. 24 of 42.
NAME OF TEST: Transient Frequency Behavior
SPECIFICATION: 47 CFR 90.214
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.19
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT was setup as shown on the attached page, following TIA/EIA-603 steps a, b, and c as a guide.
2. The transmitter was turned on.
3. Sufficient attenuation was provided so that the transmitter carrier level measured at the output of the combiner was 40 dB below the maximum input level of the test receiver. This level was recorded as step f.
4. The transmitter was turned off.
5. An RF signal generator (1) modulated with a 1 kHz tone at either 25, 12.5, or 6.25 kHz deviation, and set to the same frequency as the assigned transmitter frequency, (2) was adjusted to a level -20 dB below the level recorded for step f, as measured at the output of the combiner. This level was then fixed for the remainder of the test and is recorded at step h.
6. The oscilloscope was setup using TIA/EIA-603 steps j and k as a guide, and to either 10 ms/div (UHF) or 5 ms/div (VHF).
7. The 30 dB attenuator was removed, the transmitter was turned on, and the level of the carrier at the output of the combiner was recorded as step l.
8. The carrier on-time as referenced in TIA/EIA-603 steps m, n, and o was captured and plotted. The carrier off-time as referenced in TIA/EIA-603 steps p, q, r, and s was captured and plotted.

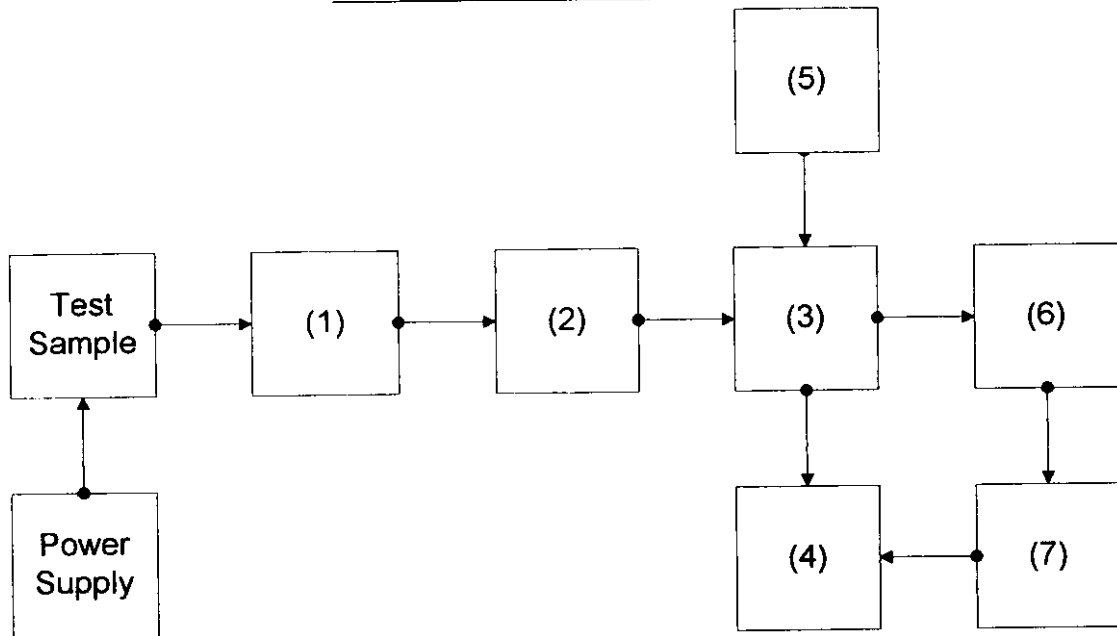
LEVELS MEASURED:

step f, dBm	= -16.9
step h, dBm	= -33.8
step l, dBm	= 17.4

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Morton Flom, P. Eng.

TRANSIENT FREQUENCY BEHAVIOR



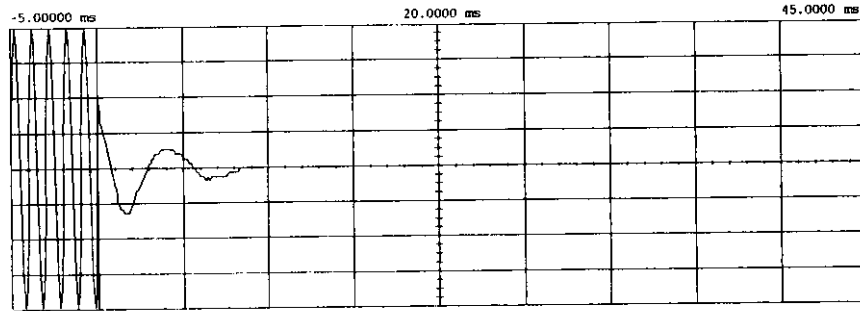
Transient Frequency Behavior

Asset	Description	s/n
(1)	<u>ATTENUATOR (Removed after 1st step)</u>	
x	i00112 Philco 30 dB	989
(2)	<u>ATTENUATOR</u>	
	i00112 Philco 30 dB	989
	i00172 Bird 30 dB	989
x	i00122 Narda 10 dB	7802
	i00123 Narda 10 dB	7802A
	i00110 Kay Variable	145-387
(3)	<u>COMBINER</u>	
x	i00154 4 x 25 Ω COMBINER	154
(4)	<u>CRYSTAL DETECTOR</u>	
x	i00159 HP 8470B	1822A10054
(5)	<u>RF SIGNAL GENERATOR</u>	
	i00018 HP 8656A	2228A03472
	i00031 HP 8656A	2402A06180
x	i00067 HP 8920A	3345U01242
(6)	<u>MODULATION ANALYZER</u>	
x	i00020 HP 8901A	2105A01087
(7)	<u>SCOPE</u>	
x	i00030 HP 54502A	2927A00209

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NAME OF TEST: Transient Frequency Behavior
 g9960242: 1999-Jun-24 Thu 09:28:00
 STATE: 0:General



Main	Timebase 5.00 ms/div	Delay/Pos 20.0000 ns	Reference Center	Mode Repetitive
channel 1	Sensitivity 600 mV/div	Offset 0.00000 V	Probe 1.000 :1	Coupling dc (1M ohm)

Trigger mode : Edge
 On Negative Edge Of Chan2
 Trigger Level
 Chan2 = -3.500 mV (noise reject ON)
 Holdoff = 40.000 ns

POWER:
 MODULATION:
 DESCRIPTION:

4W
 Ref Gen=25 kHz Deviation
 CARRIER ON TIME

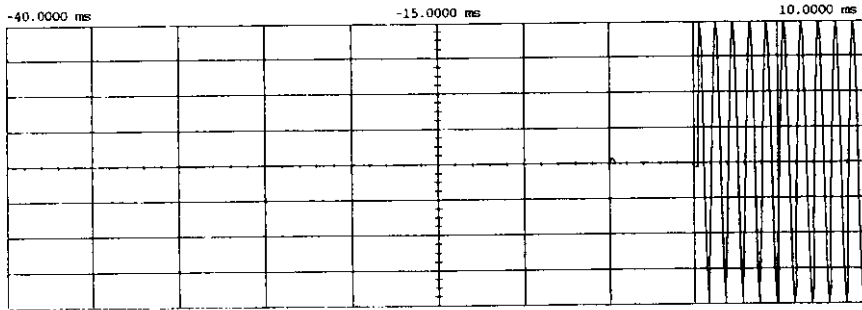
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PAGE NO.

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NAME OF TEST: Transient Frequency Behavior
g9960243: 1999-Jun-24 Thu 09:33:00
STATE: 0:General



Main	Timebase 5.00 ms/div	Delay/Pos -15.0000 ms	Reference Center	Mode Repetitive
Channel 1	Sensitivity 600 mV/div	Offset 0.00000 V	Probe 1.000 :1	Coupling dc (1M ohm)

Trigger mode : Edge
 On Positive Edge Of Chan2
 Trigger Level
 Chan2 = -1.80000 V (noise reject ON)
 Holdoff = 40.000 ns

POWER:
MODULATION:
DESCRIPTION:

4W
Ref Gen=25 kHz Deviation
CARRIER OFF TIME

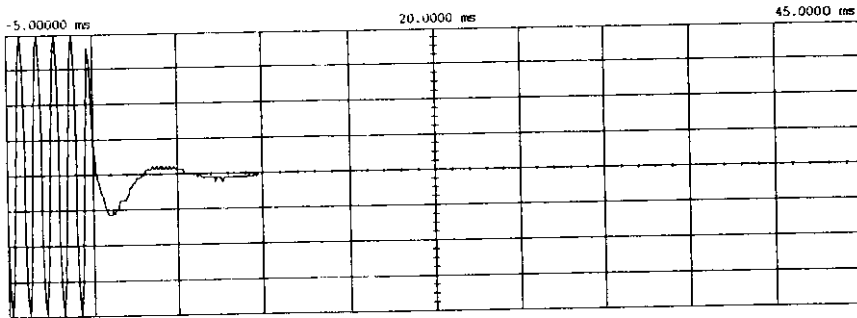
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PAGE NO.

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NAME OF TEST: Transient Frequency Behavior
99960244: 1999-Jun-24 Thu 09:49:00
STATE: 0:General



Main	Timebase 5.00 ms/div	Delay/Pos 20.0000 ms	Reference Center	Mode Repetitive
Channel 1	Sensitivity 300 mV/div	Offset 0.00000 V	Probe 1.000 :1	Coupling dc (1M ohm)

Trigger mode : Edge
On Negative Edge Of Chan2
Trigger Level
Chan2 - -3.000 mV (noise reject ON)
Holdoff - 40.000 ns

POWER:
MODULATION:
DESCRIPTION:

4W
Ref Gen=12.5 kHz Deviation
CARRIER ON TIME

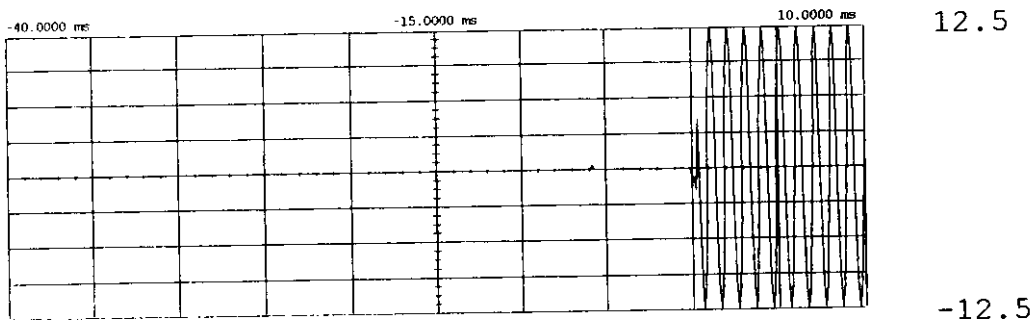
SUPERVISED BY:

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Morton Flom, P. Eng.

PAGE NO.

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NAME OF TEST: Transient Frequency Behavior
g9960245: 1999-Jun-24 Thu 09:52:00
STATE: 0:General



Main	Timebase	Delay/Pos	Reference	Mode
	5.00 ms/div	-15.0000 ms	Center	Repetitive
Channel 1	Sensitivity	Offset	Probe	Coupling
	300 mV/div	0.00000 V	1.000 :1	dc (1M ohm)

Trigger mode : Edge
On Positive Edge Of Chan2
Trigger Level
Chan2 = -1.12500 V (noise reject ON)
Holdoff = 40.000 ns

POWER:
MODULATION:
DESCRIPTION:

4W
Ref Gen=12.5 kHz Deviation
CARRIER OFF TIME

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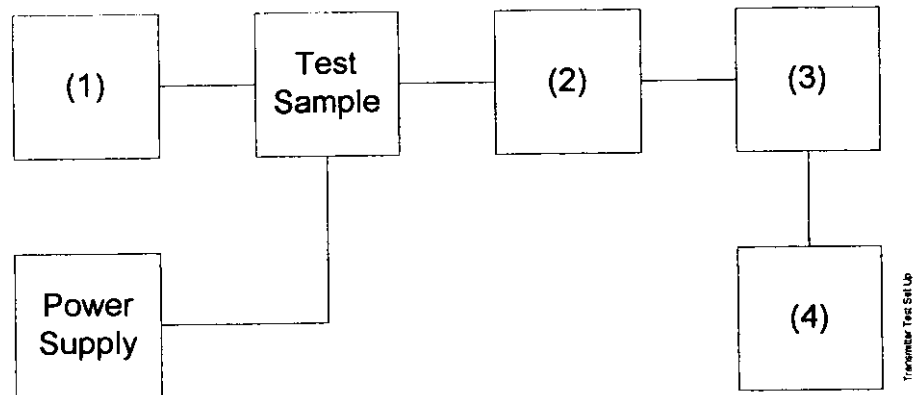
PAGE NO. 30 of 42.
NAME OF TEST: Audio Low Pass Filter (Voice Input)
SPECIFICATION: 47 CFR 2.1047(a)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.15
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up such that the audio input was connected at the input to the modulation limiter, and the modulated stage.
2. The audio output was connected at the output to the modulated stage.
3. MEASUREMENT RESULTS: ATTACHED

TRANSMITTER TEST SET-UP

- TEST A. MODULATION CAPABILITY/DISTORTION
- TEST B. AUDIO FREQUENCY RESPONSE
- TEST C. HUM AND NOISE LEVEL
- TEST D. RESPONSE OF LOW PASS FILTER
- TEST E. MODULATION LIMITING

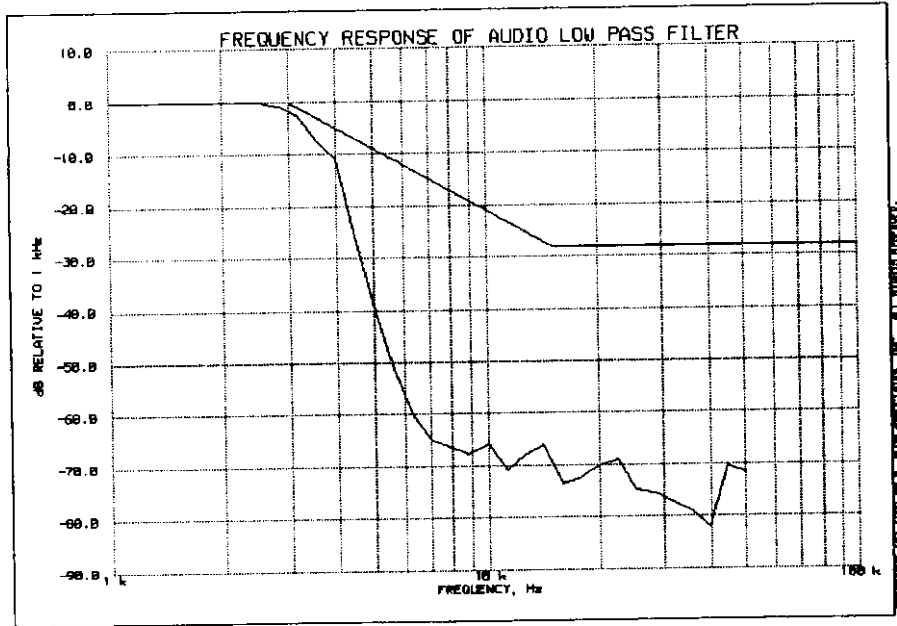


Asset	Description	s/n
(1)	<u>Audio Oscillator</u>	
	i00010 HP 204D	1105A04683
x	i00017 HP 8903A	2216A01753
x	i00118 HP 33120A	US36002064
(2)	<u>COAXIAL ATTENUATOR</u>	
	i00122 NARDA 766-10	7802
	i00123 NARDA 766-10	7802A
x	i00113 SIERRA 661A-3D	1059
	i00069 BIRD 8329 (30 dB)	10066
(3)	<u>MODULATION ANALYZER</u>	
x	i00020 HP 8901A	2105A01087
(4)	<u>AUDIO ANALYZER</u>	
x	i00017 HP 8903A	2216A01753

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NAME OF TEST: Audio Low Pass Filter (Voice Input)
g9960215: 1999-Jun-23 Wed 14:07:00
STATE: 0:General



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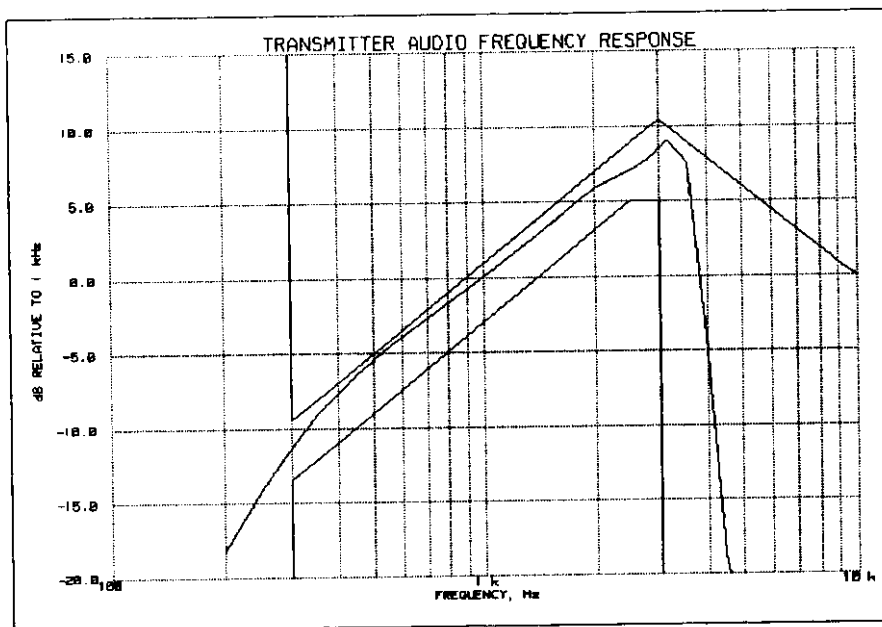
PAGE NO. 33 of 42.
NAME OF TEST: Audio Frequency Response
SPECIFICATION: 47 CFR 2.1047(a)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.6
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page.
2. The audio signal generator was connected to the audio input circuit/microphone of the EUT.
3. The audio signal input was adjusted to obtain 20% modulation at 1 kHz, and this point was taken as the 0 dB reference level.
4. With input levels held constant and below limiting at all frequencies, the audio signal generator was varied from 100 Hz to 50 kHz.
5. The response in dB relative to 1 kHz was then measured, using the HP 8901A Modulation Analyzer.
6. MEASUREMENT RESULTS: ATTACHED

PAGE NO. 34 of 42.

NAME OF TEST: Audio Frequency Response
 g9960216: 1999-Jun-23 Wed 14:12:00
 STATE: 0:General



Additional points:

FREQUENCY, Hz	LEVEL, dB
300	-11.38
20000	-31.97
30000	-31.69
50000	-32.50

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PAGE NO. 35 of 42.
NAME OF TEST: Modulation Limiting
SPECIFICATION: 47 CFR 2.1047(b)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.3
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

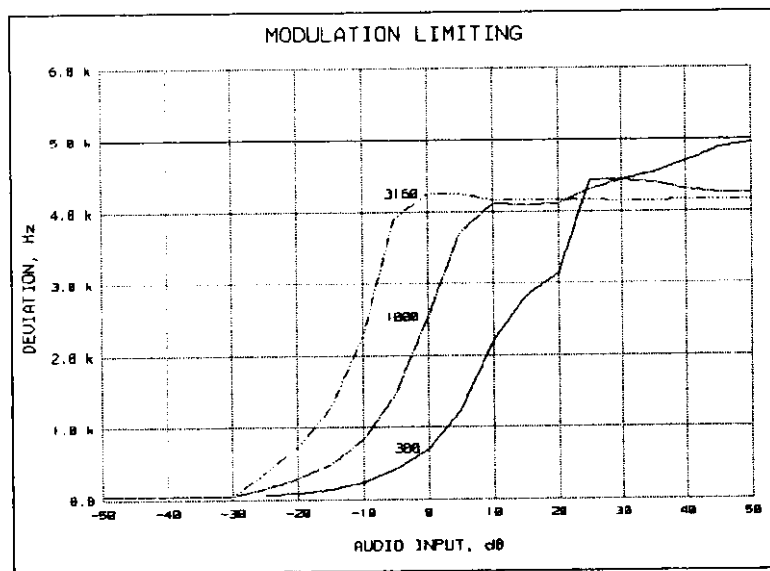
1. The signal generator was connected to the input of the EUT as for "Frequency Response of the Modulating Circuit."
2. The modulation response was measured for each of three frequencies (one of which was the frequency of maximum response), and the input voltage was varied and was observed on an HP 8901A Modulation Analyzer.
3. The input level was varied from 30% modulation (± 1.5 kHz deviation) to at least 20 dB higher than the saturation point.
4. Measurements were performed for both negative and positive modulation and the respective results were recorded.
5. MEASUREMENT RESULTS: ATTACHED

PAGE NO.

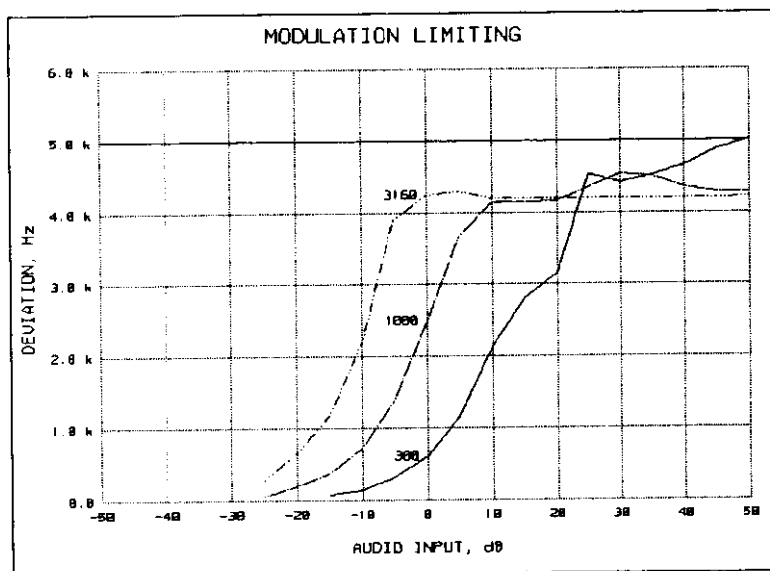
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NAME OF TEST: Modulation Limiting
g9960217: 1999-Jun-23 Wed 14:15:00
STATE: 0:General

Positive
Peaks:



Negative
Peaks:



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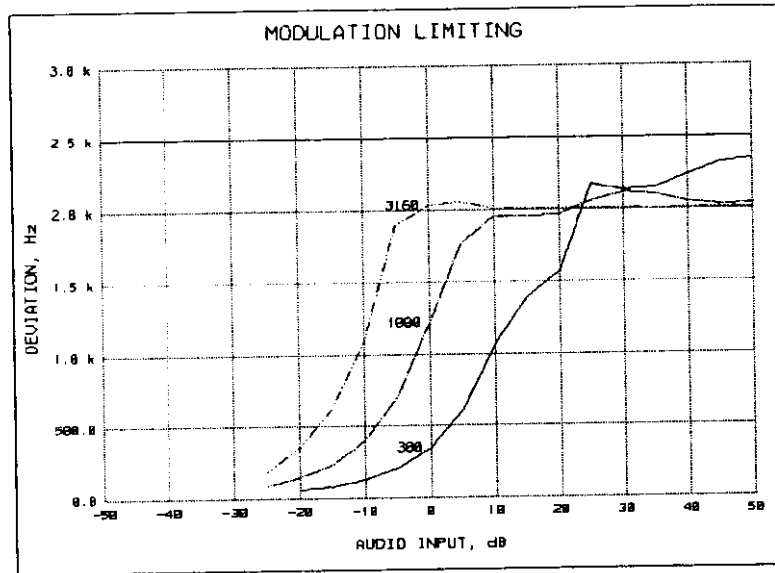
Morton Flom, P. Eng.

PAGE NO.

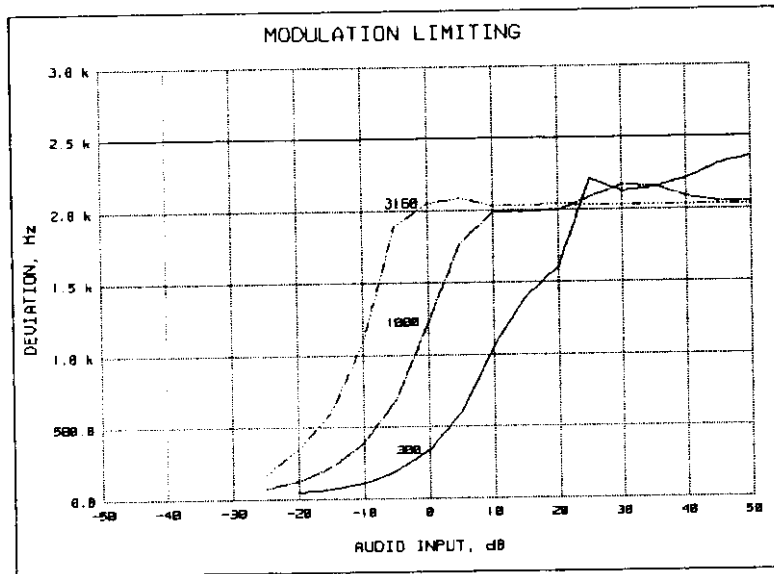
37 of 42.

NAME OF TEST: Modulation Limiting
g9960218: 1999-Jun-23 Wed 14:19:00
STATE: 0:General

Positive
Peaks:



Negative
Peaks:



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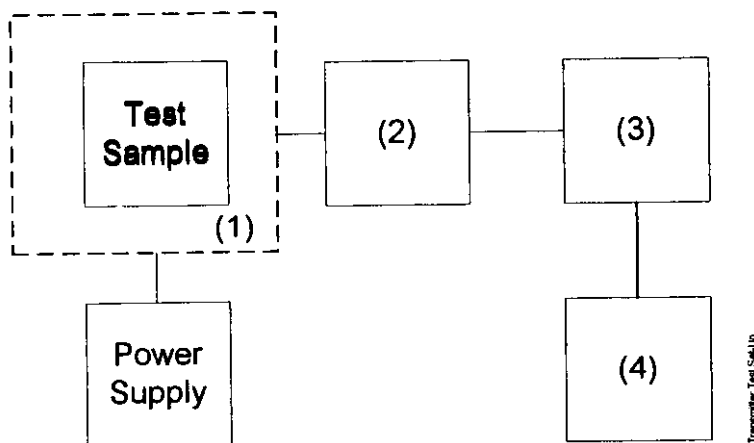
PAGE NO. 38 of 42.
NAME OF TEST: Frequency Stability (Temperature Variation)
SPECIFICATION: 47 CFR 2.1055(a) (1)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.2
TEST CONDITIONS: As Indicated
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page.
2. With all power removed, the temperature was decreased to -30°C and permitted to stabilize for three hours. Power was applied and the maximum change in frequency was noted within one minute.
3. With power OFF, the temperature was raised in 10°C steps. The sample was permitted to stabilize at each step for at least one-half hour. Power was applied and the maximum frequency change was noted within one minute.
4. The temperature tests were performed for the worst case.
5. MEASUREMENT RESULTS: ATTACHED

TRANSMITTER TEST SET-UP

- TEST A. OPERATIONAL STABILITY
- TEST B. CARRIER FREQUENCY STABILITY
- TEST C. OPERATIONAL PERFORMANCE STABILITY
- TEST D. HUMIDITY
- TEST E. VIBRATION
- TEST F. ENVIRONMENTAL TEMPERATURE
- TEST G. FREQUENCY STABILITY: TEMPERATURE VARIATION
- TEST H. FREQUENCY STABILITY: VOLTAGE VARIATION

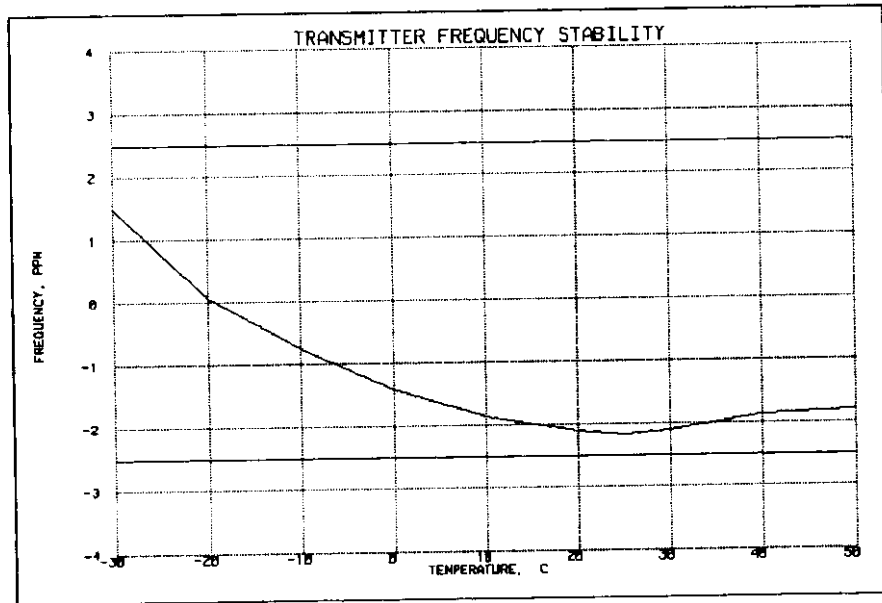


Asset	Description	s/n
<u>(1) TEMPERATURE, HUMIDITY, VIBRATION</u>		
<u>x</u>	i00027 Tenny Temp. Chamber	9083-765-234
<u> </u>	i00 Weber Humidity Chamber	
<u> </u>	i00 L.A.B. RVH 18-100	
<u>(2) COAXIAL ATTENUATOR</u>		
<u> </u>	i00122 NARDA 766-10	7802
<u> </u>	i00123 NARDA 766-10	7802A
<u>x</u>	i00113 SIERRA 661A-3D	1059
<u> </u>	i00069 BIRD 8329 (30 dB)	10066
<u>(3) R.F. POWER</u>		
<u> </u>	i00014 HP 435A POWER METER	1733A05839
<u>x</u>	i00039 HP 436A POWER METER	2709A26776
<u>x</u>	i00020 HP 8901A POWER MODE	2105A01087
<u>(4) FREQUENCY COUNTER</u>		
<u> </u>	i00042 HP 5383A	1628A00959
<u>x</u>	i00019 HP 5334B	2704A00347
<u>x</u>	i00020 HP 8901A	2105A01087

PAGE NO.

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NAME OF TEST: Frequency Stability (Temperature Variation)
g9960219: 1999-Jun-24 Thu 10:42:00
STATE: 0:General



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PAGE NO. 41 of 42.
NAME OF TEST: Frequency Stability (Voltage Variation)
SPECIFICATION: 47 CFR 2.1055(b)(1)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.2
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT was placed in a temperature chamber at 25±5°C and connected as for "Frequency Stability - Temperature Variation" test.
2. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value measured at the input to the EUT.
3. The variation in frequency was measured for the worst case.

RESULTS: Frequency Stability (Voltage Variation)
g9960225: 1999-Jun-23 Wed 14:40:24
STATE: 0:General

LIMIT, ppm = 2.5
LIMIT, Hz = 405
BATTERY END POINT (Voltage) = 6.4

% of STV	Voltage	Frequency, MHz	Change, Hz	Change, ppm
85	6.37	162.019990	-10	-0.06
100	7.5	162.020000	0	0.00
115	8.62	162.020010	10	0.06
85	6.4	162.020000	0	0.00

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PAGE NO. 42 of 42.
NAME OF TEST: Necessary Bandwidth and Emission Bandwidth
SPECIFICATION: 47 CFR 2.202(g)

MODULATION = 16K0F3E

NECESSARY BANDWIDTH CALCULATION:

MAXIMUM MODULATION (M), kHz = 3
 MAXIMUM DEVIATION (D), kHz = 5
 CONSTANT FACTOR (K) = 1
 NECESSARY BANDWIDTH (B_N), kHz = (2 x M) + (2 x D x K)
 = 16.0

MODULATION = 11K0F3E

NECESSARY BANDWIDTH CALCULATION:

MAXIMUM MODULATION (M), kHz = 3
 MAXIMUM DEVIATION (D), kHz = 2.5
 CONSTANT FACTOR (K) = 1
 NECESSARY BANDWIDTH (B_N), kHz = (2 x M) + (2 x D x K)
 = 11.0

SUPERVISED BY:

Morton Flom, P. Eng.

TESTIMONIAL
AND
STATEMENT OF CERTIFICATION

THIS IS TO CERTIFY THAT:

1. THAT the application was prepared either by, or under the direct supervision of, the undersigned.
2. THAT the technical data supplied with the application was taken under my direction and supervision.
3. THAT the data was obtained on representative units, randomly selected.
4. THAT, to the best of my knowledge and belief, the facts set forth in the application and accompanying technical data are true and correct.

CERTIFYING ENGINEER:


Morton Flom, P. Eng.

STATEMENT OF QUALIFICATIONS

EDUCATION:

1. B. ENG. in ENGINEERING PHYSICS, 1949, McGill University, Montreal, Canada.
2. Post Graduate Studies, McGill University & Sir George Williams University, Montreal.

PROFESSIONAL AFFILIATIONS:

1. ARIZONA SOCIETY OF PROFESSIONAL ENGINEERS (NSPE), #026 031 821.
2. ORDER OF ENGINEERS (QUEBEC) 1949. #45 34.
3. ASSOCIATION OF PROFESSIONAL ENGINEERS, GEOPHYSICISTS & GEOLOGISTS OF ALBERIA #5916.
4. REGISTERED ENGINEERING CONSULTANT - INDUSTRY CANADA, Certification & Engineering Bureau.
5. IEEE, Lifetime member no. 041/204 (Member since 1947).

EXPERIENCE:

1. Research/Development/Senior Project Engineer. R.C.A. LIMITED (4 years).
2. Owner/Chief Engineer of Electronics. Design/Manufacturing & Cable TV Companies (10 years)
3. CONSULTING ENGINEER (over 25 years).



MORTON FLOM, P. Eng.